

PMZ250UN

N-channel TrenchMOS extremely low level FET

Rev. 01 — 21 February 2008

Product data sheet

1. Product profile

1.1 General description

N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology.

1.2 Features

- Profile 55 % lower than SOT23
- Lower on-state resistance
- Leadless package

- Footprint 90 % smaller than SOT23
- Low threshold voltage
- Fast switching

1.3 Applications

- Driver circuits
- DC-to-DC converters

Load switching in portable appliances

1.4 Quick reference data

- $V_{DS} \le 20 \text{ V}$
- \blacksquare R_{DSon} \leq 300 m Ω

- $I_D \le 2.28 \text{ A}$
- Arr P_{tot} \leq 2.50 W

2. Pinning information

Table 1. Pinning

Pin	Description	Simplified outline	Symbol
1	gate (G)		
2	source (S)	1 3	D
3	drain (D)	2	
		Transparent top view	
		SOT883 (SC-101)	mbb076 S



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3. Ordering information

Table 2. Ordering information

Type number	Package			
	Name	Description	Version	
PMZ250UN	SC-101	leadless ultra small plastic package; 3 solder lands; body $1.0 \times 0.6 \times 0.5$ mm	SOT883	

4. Limiting values

CAUTION



This device is sensitive to ElectroStatic Discharge (ESD). Observe precautions for handling electrostatic sensitive devices.

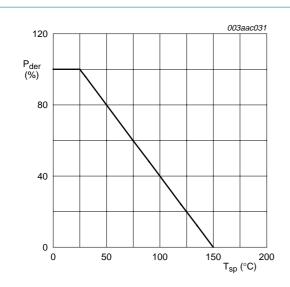
Such precautions are described in the ANSI/ESD~S20.20, IEC/ST~61340-5, JESD625-A or equivalent standards.

Table 3. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

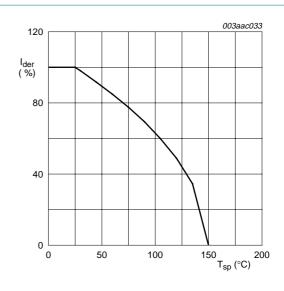
		A 11/1			
Symbol	Parameter	Conditions	Min	Max	Unit
V_{DS}	drain-source voltage	$25 ^{\circ}\text{C} \le \text{T}_{\text{j}} \le 150 ^{\circ}\text{C}$	-	20	V
V_{DGR}	drain-gate voltage (DC)	$25~^{\circ}\text{C} \le \text{T}_{\text{j}} \le 150~^{\circ}\text{C}; \text{R}_{\text{GS}} = 20~\text{k}\Omega$	-	20	V
V_{GS}	gate-source voltage		-	±8	V
I _D	drain current	T_{sp} = 25 °C; V_{GS} = 4.5 V; see <u>Figure 2</u> and <u>3</u>	-	2.28	Α
		$T_{sp} = 100 ^{\circ}\text{C}$; $V_{GS} = 4.5 \text{V}$; see Figure 2	-	1.44	Α
I _{DM}	peak drain current	T_{sp} = 25 °C; pulsed; $t_p \le 10 \mu s$; see Figure 3	-	4.56	Α
P _{tot}	total power dissipation	T _{sp} = 25 °C; see <u>Figure 1</u>	-	2.50	W
T _{stg}	storage temperature	-	-55	+150	°C
Tj	junction temperature	-	-55	+150	°C
Source-	drain diode				
Is	source current	T _{sp} = 25 °C	-	2.28	Α
I _{SM}	peak source current	T_{sp} = 25 °C; pulsed; $t_p \le 10 \mu s$	-	4.56	Α
Electros	tatic discharge				
V_{esd}	electrostatic discharge voltage	all pins	-		
		human body model; C = 100pF; R = 1.5 k Ω	-	60	V
		machine model; C = 200 pF	-	30	V
		machine model, C = 200 pr	-	30	

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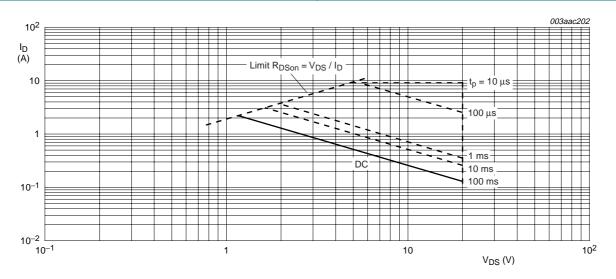
$$P_{der} = \frac{P_{tot}}{P_{tot(25^{\circ}C)}} \times 100 \%$$

Fig 1. Normalized total power dissipation as a function of solder point temperature



$$I_{der} = \frac{I_D}{I_{D(25^{\circ}C)}} \times 100 \%$$

Fig 2. Normalized continuous drain current as a function of solder point temperature



 T_{sp} = 25 °C; I_{DM} is single pulse

Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage

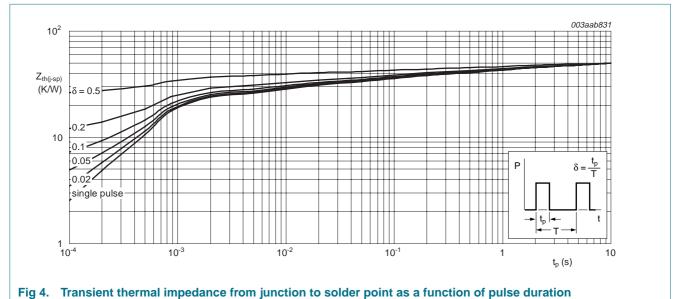
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5. Thermal characteristics

Table 4. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j-sp)}$	thermal resistance from junction to solder point	see Figure 4	-	-	50	K/W
R _{th(j-a)}	thermal resistance from junction to ambient	minimum footprint	<u>[1]</u> _	670	-	K/W

[1] Mounted on a printed-circuit board; vertical in still air.



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6. Characteristics

Table 5. Characteristics

 $T_j = 25 \,^{\circ}C$ unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static ch	aracteristics					
V _{(BR)DSS}	drain-source breakdown	$I_D = 10 \mu A; V_{GS} = 0 V$				
	voltage	T _j = 25 °C	20	-	-	V
		T _j = −55 °C	18	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	$I_D = 0.25 \text{ mA}$; $V_{DS} = V_{GS}$; see <u>Figure 9</u> and <u>10</u>				
		T _j = 25 °C	0.45	0.7	0.95	V
		T _j = 150 °C	0.25	-	-	V
		T _j = −55 °C	-	-	1.15	V
I _{DSS}	drain leakage current	$V_{DS} = 20 \text{ V}; V_{GS} = 0 \text{ V}$				
		T _j = 25 °C	-	-	1	μΑ
		T _j = 150 °C	-	-	100	μΑ
I_{GSS}	gate leakage current	$V_{GS} = \pm 8 \text{ V}; V_{DS} = 0 \text{ V}$	-	10	100	nΑ
R_{DSon}	drain-source on-state resistance	$V_{GS} = 4.5 \text{ V}$; $I_D = 0.2 \text{ A}$; see Figure 6 and 8				
		T _j = 25 °C	-	250	300	$m\Omega$
		T _j = 150 °C	-	400	480	$m\Omega$
		$V_{GS} = 2.5 \text{ V}$; $I_D = 0.1 \text{ A}$; see Figure 6 and 8	-	320	400	$m\Omega$
		V_{GS} = 1.8 V; I_D = 0.075 A; see <u>Figure 6</u> and <u>8</u>	-	420	600	$m\Omega$
Dynamic	characteristics					
Q _{G(tot)}	total gate charge	$I_D = 1 \text{ A}$; $V_{DS} = 10 \text{ V}$; $V_{GS} = 4.5 \text{ V}$; see	-	0.89	-	nC
Q_{GS}	gate-source charge	Figure 11 and 12	-	0.13	-	nC
Q_{GD}	gate-drain charge		-	0.18	-	nC
C _{iss}	input capacitance	$V_{GS} = 0 \text{ V}; V_{DS} = 20 \text{ V}; f = 1 \text{ MHz}; \text{see}$	-	45	-	pF
C _{oss}	output capacitance	Figure 14	-	11	-	pF
C _{rss}	reverse transfer capacitance		-	7	-	pF
t _{d(on)}	turn-on delay time	V_{DS} = 10 V; R_L = 10 Ω ; V_{GS} = 4.5 V; R_G = 6 Ω	-	4.5	-	ns
t _r	rise time		-	10	-	ns
t _{d(off)}	turn-off delay time		-	18.5	-	ns
t _f	fall time		-	5	-	ns
Source-	drain diode					
V_{SD}	source-drain voltage	$I_S = 0.3 \text{ A}; V_{GS} = 0 \text{ V}; \text{ see } \frac{\text{Figure } 13}{\text{ Figure } 13}$	-	0.80	1.2	V

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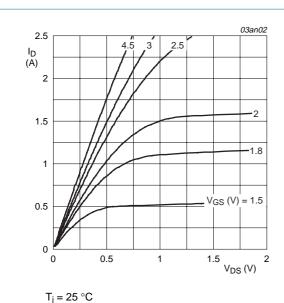
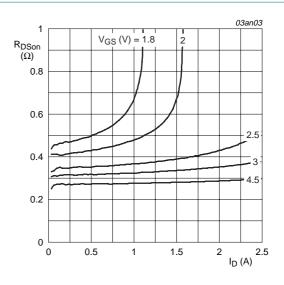


Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values



 $T_j = 25 \, ^{\circ}C$

Fig 6. Drain-source on-state resistance as a function of drain current; typical values

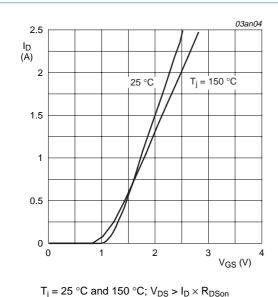
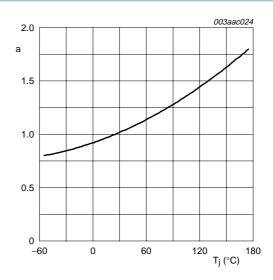


Fig 7. Transfer characteristics: drain current as a function of gate-source voltage; typical values

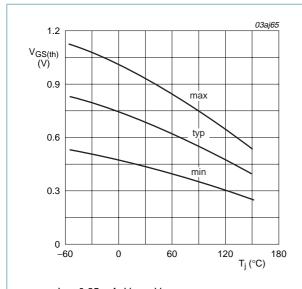


$$a = \frac{R_{DSon}}{R_{DSon(25^{\circ}C)}}$$

Fig 8. Normalized drain-source on-state resistance factor as a function of junction temperature

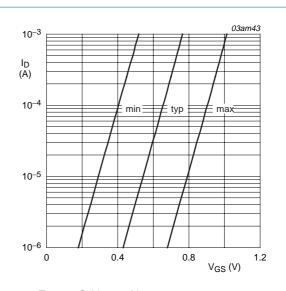
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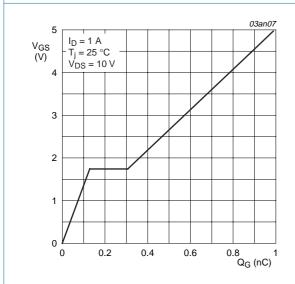
 I_D = 0.25 mA; V_{DS} = V_{GS}

Fig 9. Gate-source threshold voltage as a function of junction temperature



 $T_j = 25 \,^{\circ}C; \, V_{DS} = 5 \, V$

Fig 10. Sub-threshold drain current as a function of gate-source voltage



 $I_D = 1 A; V_{DS} = 10 V$

Fig 11. Gate-source voltage as a function of gate charge; typical values

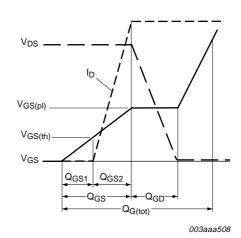
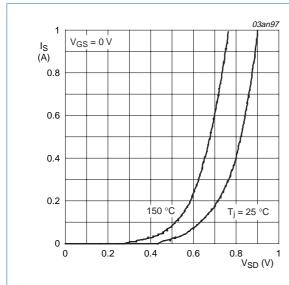


Fig 12. Gate charge waveform definitions

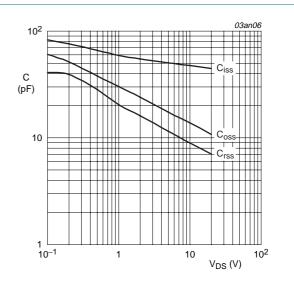
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 T_j = 25 °C and 150 °C; V_{GS} = 0 V

Fig 13. Source current as a function of source-drain voltage; typical values



 $V_{GS} = 0 \text{ V}; f = 1 \text{ MHz}$

Fig 14. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

PMZ250UN **NXP Semiconductors**

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Package outline

Leadless ultra small plastic package; 3 solder lands; body 1.0 x 0.6 x 0.5 mm **SOT883** e₁ 0.5 1 mm DIMENSIONS (mm are the original dimensions) UNIT b_1 D Ε е L L_1 e₁ 0.50 0.20 0.55 0.62 1.02 0.30 0.30 mm 0.03 0.35 0.65 0.46 0.95 0.22 0.22 1. Including plating thickness REFERENCES OUTLINE **EUROPEAN** ISSUE DATE VERSION **PROJECTION** IEC **JEDEC JEITA** 03-02-05

Fig 15. Package outline SOT833 (SC-101)

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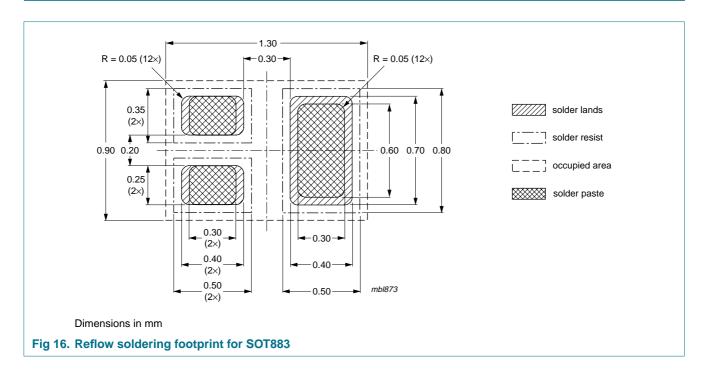
SC-101

SOT883

03-04-03

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8. Soldering



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9. Revision history

Table 6. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
PMZ250UN_1	20080221	Product data sheet	-	-

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10.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
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